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Optical Electronic Systems, Communications and Security

Guest Editors:

Prof. Dr. Gennady E. Veselov

Director of the Institute of Computer Technology and Information Security, Southern Federal University, 344006 Rostov-on-Don, Russia

Dr. Anton Pljonkin

Institute of Computer Technologies and Information Security, Southern Federal University, 105/42 Bolshaya Sadovaya Str., 344006 Rostov-on-Don, Russia

Dr. Lilia Sabantina

Junior Research Group Nanomaterias, Faculty of Engineering and Mathematics, Bielefeld University of Applied Sciences, Interaktion 1, 33619 Bielefeld, Germany **Message from the Guest Editors**

This Special Issue invites original reviews and articles on optical electronic systems, communications, control and systems engineering, electrical and electronic engineering, nanomaterials, quantum optics in quantum cryptography, quantum protocols, optical circuits and components, vulnerabilities, and quantum key distribution systems.

Deadline for manuscript submissions: **closed (30 November 2022)**









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Editor-in-Chief

Prof. Dr. Flavio Canavero

Department of Electronics and Telecommunications, Politecnico di Torino, 10129 Torino, Italy

Message from the Editor-in-Chief

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